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Document information

Info	Content
Keywords	NTAG, NTAG I ² C, NTAG I ² C <i>plus</i> , NTAG Smart Sensor, RFID Tag, LPC8N04, Antenna Theory, Antenna Design, Measurement Methods, Antenna Design Procedure
Abstract	NTAG ICs need to be connected to an antenna to turn them into an operational RFID tag. This application note provides guidance for designing such antenna.



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Revision history

Rev	Date	Description
1.7	20180115	Small text correction
1.6	20171113	NTAG Smart Sensor and LPC8N04 added
1.5	20160427	Security status changed into COMPANY PUBLIC
1.4	20160201	NTAG I ² C and NTAG I ² C plus added
1.3	20130408	NTAG210 and NTAG212 added
1.1	20121106	Small text correction
1.0	20121012	First release

Contact information

For more information, please visit: http://www.nxp.com

NTAG Antenna Design Guide

1. Introduction

NXP Semiconductors' NTAG ICs provide a platform for the design of NFC Forum Type 2 Tag compliant tags and are designed to be used with NFC Forum's ISO/IEC 14443A enabled devices.

The RF interface complies with part 2 and 3 of the ISO/IEC 14443A standard [4] and [6].

Communication with the NTAG IC can only be established when the IC is connected to an antenna. This document provides all necessary information to design antennas for NXP NTAG ICs that are compatible with NFC compliant read / write devices.

Note: in RFID terminology, an antenna is sometimes referred to as a coil.

1.1 Structure of the document

This document is subdivided into several parts.

Section 2 provides an overview of the theory of an antenna design.

Section <u>3</u> contains a description of various measurement methods to measure and calculate the equivalent circuits of an antenna. This section also provides a list of applicable instruments.

Section <u>4</u> provides a practical procedure for the development of rectangular, square or round (circular) antennas with cupper wire, etched or printed antenna material.

Section <u>5</u> contains a link to the ISO/IEC 14443 standard that defines six antenna classes. NXP Semiconductors offers reference designs for "Class 4", "Class 5" and "Class 6" antennas that can be used to design an NFC tag based on the NTAG. This section also contains the Gerber files for the reference designs.

Some NTAG ICs, like the NTAG203F, NTAG213F, NTAG216F offer a so-called "Field detect" pin that can be used to activate an electronic device. (See <u>AN11141</u> and <u>AN11383</u> for description). On top NTAG I²C, NTAG I²C *plus* features an I²C interface to be connected to e.g. a microcontroller. NXP Semiconductors offers demo boards for the NTAG203F, NTAG216F, NTAG I²C and NTAG I²C *plus* that can be used to experience the functionality of the NTAG. Section <u>6</u> contains a description of the demo boards and contains the Gerber files for the reference antenna designs.

The NTAG Smart Sensor NHS3100 is an IC with an ARM Cortex M0+ microcontroller and Flash memory optimized for temperature monitoring and logging. With its embedded NFC interface, internal temperature sensor and direct battery connection, it supports an effective system solution with a minimal number of external components.

The NTAG Smart Sensor NHS3152 is an IC optimized for realizing therapy adherence monitoring and logging. With its embedded NFC interface, a resistive network sensing-interface, an internal temperature sensor and a direct battery connection. These features support an effective system solution with a minimal number of external components and a single layer foil implementation for pill usage monitoring. The NHS3152 works either battery-powered or NFC-powered.

The LPC8N04 is part of LPC MCU families, an ARM Cortex M0+ microcontroller with integrated Flash, SRAM, EEPROM memory and NFC ISO14443 type A interface. It

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supports MCUXpresso, Keil and IAR IDEs for an easier development environment as well as a variety of single chip NFC MCU applications.

Section 7 contains a list of abbreviations that are used throughout the document.

Customers that are familiar with antenna design can go straight to section 4 for the design of their antenna.

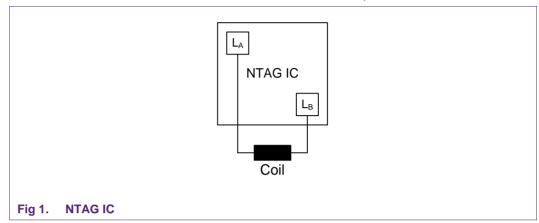
Note: Section 2, 3 and 4 are written for an antenna design on a label base, but are also applicable for PCB antennas. It is recommended to carry out read/ write tests with the tags and all different read / write devices that will be used with the tags.

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2. Antenna theory

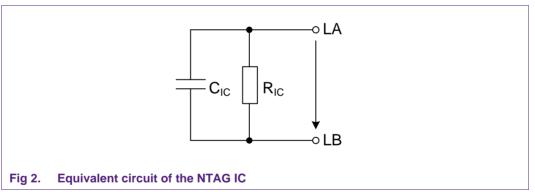
2.1 NTAG IC connections

The NTAG IC needs to be connected to the antenna with the pads L_A and L_B



2.1.1 NTAG IC equivalent circuit

The following simple equivalent circuit describes the properties of the NTAG IC which are relevant for the antenna design.



2.1.2 NTAG IC input capacitance C_{IC}

This electrical parameter of the NTAG IC is the most important factor for the antenna design. The form factor and the parameters of the antenna are affected by the input capacitance

The input capacitance depends on the applied chip voltage.

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The following table specifies the value of this capacitance for the given type of NTAG IC.

Table 1. Capacitance value of NTAG IC

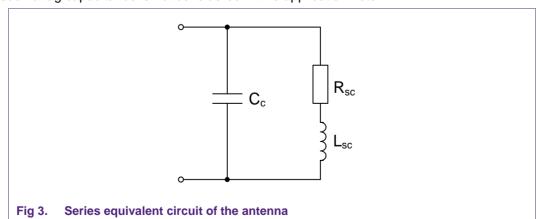
Туре		C ic	Measurement conditions
NT2L1011G0DUx	NTAG210	17 pF	$V_{\text{LA-LB}} = 2 \text{ Vrms}, f = 13.56 \text{ MHz}^{1}$
NT2L1211G0DUx	NTAG212	17 pF	$V_{LA-LB} = 2 \text{ Vrms}, f = 13.56 \text{ MHz}^1$
NT2H0301F0DTx	NTAG203F	50 pF	$V_{LA-LB} = 2 \text{ Vrms}, f = 13.56 \text{ MHz}^1$
NT2H1311G0DUx	NTAG213	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$
NT2H1511G0DUx	NTAG215	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$
NT2H1611G0DUx	NTAG216	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$
NT2H1301F0DTL	NTAG213F	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$
NT2H1601F0DTL	NTAG216F	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$
NT3H1x01W0x	NTAG I ² C 1k / 2k	50pF	$V_{LA-LB} = 2.4 \text{ Vrms}, f = 13.56 \text{ MHz}$
NT3H2x11W0x	NTAG I ² C <i>plu</i> s 1k / 2k	50pF	$V_{LA-LB} = 2.4 \text{ Vrms}, f = 13.56 \text{ MHz}$
NHS3100	NHS3100	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$
NHS3152	NHS3152	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$
LPC8N04FHI24	LPC8N04	50pF	$V_{LA-LB} = 1.5 \text{ Vrms}, f = 13.56 \text{ MHz}$

¹ Measured with HP4285A LCR meter

2.2 Series and parallel equivalent circuits

2.2.1 Series equivalent circuit of the antenna

The antenna can be described by an inductance $L_{\rm sc}$ in series to a loss resistance $R_{\rm sc}$. The antenna capacitance $C_{\rm c}$ is in parallel to this series circuit. This capacitance consists of the inter-turn capacitance and a possibly designed tag capacitance. The design of such a tag capacitance is not considered in this application note.



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The antenna quality factor is calculated by

$$Q_{sc} = \frac{2 \cdot \pi \cdot f_{op} \cdot L_{sc}}{R_{sc}}$$

with operating frequency $f_{op} = 13.56$ MHz.

2.2.2 Parallel equivalent circuit of the antenna

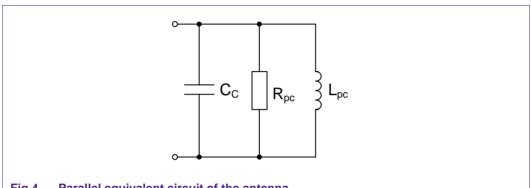


Fig 4. Parallel equivalent circuit of the antenna

The following applies:

$$L_{pc} = \frac{R_{sc}^2 + (2 \cdot \pi \cdot f_{op} \cdot L_{sc})^2}{(2 \cdot \pi \cdot f_{op})^2 \cdot L_{sc}} = L_{sc} \cdot \frac{1 + Q_{sc}^2}{Q_{sc}^2}$$

$$R_{pc} = \frac{R_{sc}^2 + \left(2 \cdot \pi \cdot f_{op} \cdot L_{sc}\right)^2}{R_{sc}} = R_{sc} \cdot \left(1 + Q_{sc}^2\right)$$

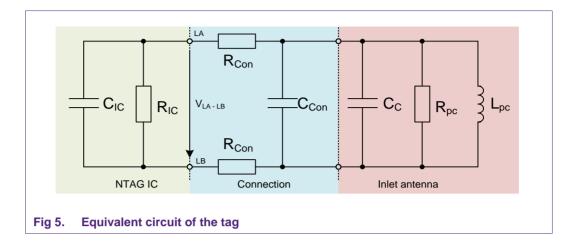
$$Q_{pc} = \frac{R_{pc}}{2 \cdot \pi \cdot f_{op} \cdot L_{pc}} = Q_{sc}$$

For the further calculations, the parallel equivalent circuit was chosen to simplify the resonance circuit. This makes calculation easier.

2.2.3 Equivalent circuit of the tag

The following figure shows the equivalent circuit of the whole tag.

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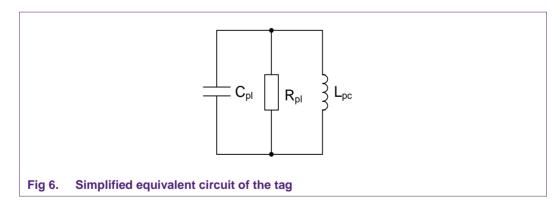
The NTAG IC capacitance C_{IC} together with the antenna capacitance and the parasitic connection capacitance forms a resonance circuit with the inductance of the antenna.

The NTAG IC input resistance $R_{\rm IC}$ together with the loss resistance of the antenna and the connection resistance defines the quality factor of the tag. This quality factor influences the threshold field strength of the tag and will be explained in the following sections.

 R_{Con} should be kept as low as possible in order not to influence the total parallel equivalent resistance of the tag R_{pl} . A relatively high connection resistance will decrease the total parallel quality factor of the tag and therefore decrease the transmission range.

 C_{Con} describes the increase of the total tag capacitance due to dielectric changes (under filler, adhesive ...) in the connection area when the chip is applied to the antenna.

For $R_{Con} \ll 1\Omega$ the following simplified circuit can be used for the tag:



Parallel equivalent capacitance of the tag

$$C_{pl} = C_{IC} + C_{Con} + C_{c}$$

Parallel equivalent resistance of the tag

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$$R_{pl} = \frac{R_{IC} \cdot R_{pc}}{R_{IC} + R_{pc}}$$

2.3 Resonance frequency and qualification factor of the tag

Based on the simplified equivalent circuit the resonance frequency f_R of the tag can be calculated with:

$$f_R = \frac{1}{2 \cdot \pi \cdot \sqrt{L_{pc} \cdot C_{pl}}}$$

The value of the NTAG IC input capacitance $C_{\rm IC}$ depends on the chip input voltage $V_{\rm LA-LB}$. Therefore, the resonance frequency of the tag changes with the IC input voltage.

Based on the simplified equivalent circuit (Fig 6) the quality factor Q of the tag at the operating frequency can be calculated with:

$$Q = \frac{R_{pl}}{2 \cdot \pi \cdot f_{op} \cdot L_{pc}}$$

The value of the NTAG IC input resistance $R_{\rm IC}$ depends on the chip input voltage $V_{\rm LA-LB}$. Therefore, also the quality factor of the tag changes with the IC input voltage.

2.3.1 Threshold resonance frequency f_{RT} and threshold quality factor Q_T

The threshold resonance frequency f_{RT} is the resulting resonance frequency for the minimum operating input voltage of the IC.

V_{LA-LB} Minimal voltage level for NTAG IC operation

$$C_{plT} = C_{ICT} + C_{Con} + C_{c}$$

C_{ICT} NTAG IC input capacitance for threshold condition

C_{plT} Parallel equivalent capacitance of the tag for threshold condition

C_{ICT} represents the NTAG IC input capacitance for minimal operating conditions and corresponds to the specified typical value.

$$f_{RT} = \frac{1}{2 \cdot \pi \cdot \sqrt{L_{pc} \cdot C_{plT}}}$$

$$R_{plT} = \frac{R_{ICT} \cdot R_{pc}}{R_{ICT} + R_{pc}}$$

R_{ICT} NTAG IC input resistance for threshold condition

R_{plT} Parallel equivalent resistance of the tag for threshold condition

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 $R_{\rm ICT}$ represents the NTAG IC input resistance for the minimal operating conditions and corresponds to the shown typical value.

$$Q_T = \frac{R_{plT}}{2 \cdot \pi \cdot f_{RT} \cdot L_{pc}}$$

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2.4 Threshold field strength H_T

This section gives formulas to calculate the threshold field strength H_T which is significant for the transmission range. The influence of the threshold resonance frequency f_{RT} and the antenna quality factor Q_{pc} on this field strength is figured out.

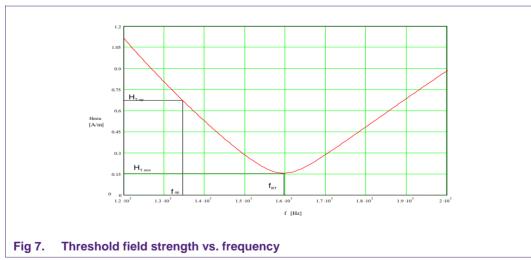
The voltage on the IC generated by the magnetic field of the reader with antenna current h is given by:

$$V_{LA-LB} = \frac{2 \cdot \pi \cdot f \cdot M}{\left(\left(1 - \left(\frac{f}{f_R}\right)^2\right)^2 + \left(\frac{2 \cdot \pi \cdot f \cdot L_{pc}}{R_{pl}}\right)^2\right)^{\frac{1}{2}}} \cdot I_1$$

With the assumption that the turns of the tag antenna are concentrated on the average antenna dimensions, the threshold field strength for NTAG IC operation can be calculated with:

$$H_{T} = \frac{\left(\left(1 - \left(\frac{f}{f_{RT}}\right)^{2}\right)^{2} + \left(\frac{2 \cdot \pi \cdot f \cdot L_{pc}}{R_{plT}}\right)^{2}\right)^{\frac{1}{2}}}{2 \cdot \pi \cdot f \cdot \mu_{0} \cdot N_{c} \cdot A_{c}} \cdot V_{LA-LB\,\mathrm{min}}$$

The following figure shows the behavior of threshold field strength H_T versus the frequency f of the inducing magnetic field for a tag with the threshold resonance frequency f_{RT} .



The curve of the threshold field strength reaches its minimum at the threshold resonance frequency f_{RT} of the tag. For $f=f_{RT}$ the minimal threshold field strength H_{Tmin} results in:

$$H_{T \min} = \frac{L_{pc}}{\mu_0 \cdot N_c \cdot A_c \cdot R_{plT}} \cdot V_{LA-LB \min}$$

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At the operating frequency f_{op} the threshold field strength results in:

$$H_{\textit{Top}} = \frac{\left(\left(1 - \left(\frac{f_{\textit{op}}}{f_{\textit{RT}}}\right)^2\right)^2 + \left(\frac{2 \cdot \pi \cdot f_{\textit{op}} \cdot L_{\textit{pc}}}{R_{\textit{plT}}}\right)^2\right)^{1/2}}{2 \cdot \pi \cdot \mu_0 \cdot f_{\textit{op}} \cdot N_c \cdot A_c} \cdot V_{\textit{LA-LB}\,\text{min}}$$

Lowest operating field strength is reached if $f_{RT} = f_{op} = 13.56$ MHz resulting in $H_T = H_{Tmin}$.

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3. Antenna measurement methods

3.1 Antenna characterization

The equivalent circuit of the antenna (without IC) can be determined by using the following measuring instruments with associated measuring principals.

3.1.1 Impedance analyzer with equivalent circuit calculation

The following instruments are examples of equipment that can be used to determine the value of the parameter of a serial or parallel equivalent circuit by measuring the magnitude and the phase of the impedance of the connected antenna.

Instruments: HP 4194A – Impedance analyzer

HP 4294A – LCR impedance analyzer

HP 4195A - Network/ Spectrum analyzer

HP 4295A - LCR meter

The antenna under test must be connected to the analyzer by using an appropriate test fixture that does not influence the antenna parameters (no metal parts near the antenna etc.).

Before each measurement the analyzer must be calibrated (open, short and load compensation at the calibration plane) and the test fixture compensated (open, short compensation at the connection points) according to the instruments manual.

Settings: |Z|, ⊙

Center frequency: 13.56MHz

Span: ± 4 MHz

Parallel equivalent circuit is used for measurement. The values can then be used for the antenna design procedure.

3.1.2 Method for ISO/IEC 7810 ID-1 sized card

For ID-1 sized cards a measurement method is available.

Measurement principle:

A measurement (or calibration) antenna must be connected to the instrument. A short-calibration must be performed with this measurement antenna connected to the terminals of the instrument.

The measuring antenna itself is described in section 6.1 of [1] and meets the following requirements.

- Roughly the same dimensions as the calibration antenna
- 1 turn
- Low parasitic capacitance
- High quality factor; Q ~ 40

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The measurement of the bare short-compensated measuring antenna (no tag antenna next to it) shows very low impedance. For tag characterization, it has to be positioned without any distance and covering the measuring antenna completely. The measurement of R and X shows a well-defined maximum of the resistance. The resonance frequency of the tag is found at the maximum of R.

Resonance frequency: $f_R @ / R = maximum$

Measurement preparations:

- The measuring antenna must be connected to the test fixture of the instrument
- A short correction of the measuring antenna must be performed and switched on
- Settings: R, X, frequency sweep (if using LCR meter this must be done manually or by software)
- Output power must be set to 15mA.

3.1.3 Impedance analyzer or LCR meter

Measurement principle:

A measurement antenna has to be connected to the instrument. A short-calibration has to be performed with this measurement antenna connected to the terminals of the instrument.

The measuring antenna has to meet the following requirements:

- Roughly the same dimension as the card antenna
- 1 turn
- Low parasitic capacitance
- High quality factor; Q~40

The measurement of the bare compensated measuring antenna (no tag antenna next to it) shows very low impedance. For tag characterization, it has to be positioned close to the measuring antenna (approx. 1cm distance). The measurement (R, X) of the measuring antenna shows a well-defined maximum of the resistance. The resonance frequency is found at this maximum of R.

Resonance frequency: $f_R @ / R = \text{maximum}$

Measurement preparations:

- The measuring antenna must be connected to the test fixture of the instrument
- A short correction of the measuring antenna must be performed and switched on
- Settings: R, X, frequency sweep (for LCR meter this must be done manually or by software)
- Use highest possible output power of the measurement equipment

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3.1.4 Reference measurement using capacitor

This measurement generally only verifies the antenna, because there is no IC connected. It can be used to verify the tuning of a tag.

Measurement principle:

Instead of a tag consisting of antenna with NTAG IC, now a dummy tag consisting of antenna with reference capacitor is used.

The reference capacitor should meet the following requirements:

- Value of reference capacitor optimal is the nominal capacitance of the used NTAG
 IC.
- · High quality capacitors must be used; capacitors with a low tolerance

A measuring antenna must be connected to the instrument. A short-calibration must be performed with this measuring antenna connected to the terminals of the instrument.

The measuring antenna must meet the following requirements:

- Roughly the same dimension as the card antenna
- 1 turn
- · Low parasitic capacitance
- High quality factor; Q~40

The measurement of the bare compensated measuring antenna (no tag antenna next to it) shows very low impedance. The tag must be positioned close to the measuring antenna (approx. 1cm distance). The measurement (R, X) of the measuring antenna shows a well-defined maximum of the resistance. The resonance frequency is found at this maximum of R.

Resonance frequency: $f_R @ / R = \text{maximum}$

Measurement preparations:

- The measuring antenna must be connected to the test fixture of the instrument
- A short correction of the measuring antenna must be performed and switched on

Settings: R, X, frequency sweep

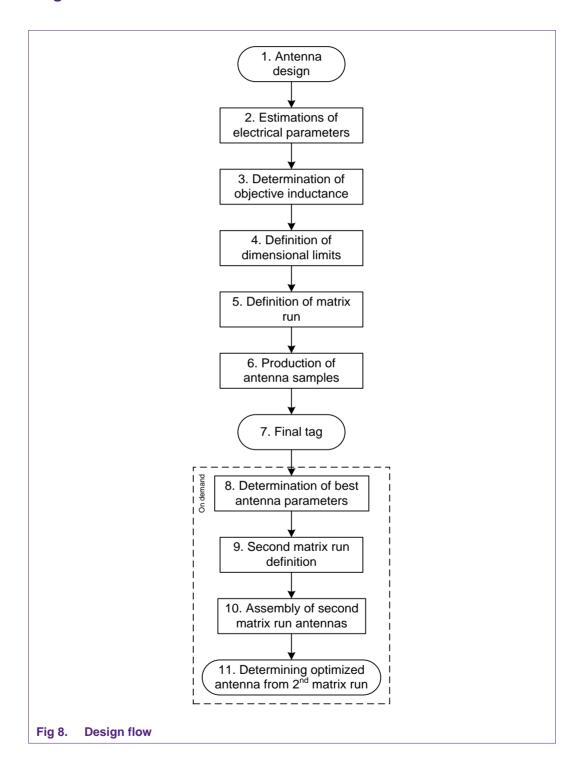
3.1.5 Minimum field strength measurement

With this measurement, the frequency is determined where the tag can be operated with the lowest field strength. This frequency is called resonance frequency.

This measurement is performed with the measurement configuration as it is used in [1].

4. Antenna design procedure

4.1 Design flow



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4.2 Estimation of electrical parameters

4.2.1 Ideal threshold frequency f_{IDEAL} determination

Based on the application it is necessary to determine what resonance frequency the inlet should be tuned to.

For single tag operation, a tuning slightly above 13.56 MHz would lead to maximum read/write distance. Due to manufacturing tolerances, a nominal frequency of 14.5 MHz for single tag operation is recommended.

4.2.2 Estimation of the antenna capacitance C_c

To be able to calculate the approximate objective inductance L_0 of the antenna, it is necessary to estimate the capacitance C_0 of the antenna. This capacitance can be split up into the always existing antenna inter turn capacitance C_{it} , the additional capacitance due to possibly realized bridge C_{br} and a possibly designed on tag capacitance C_{in} .

The antenna inter turn capacitance C_{it} is dependent upon the technology used for the antenna manufacturing. The following table shows the estimated values for some oftenused technologies.

Table 2. Antenna inter turn capacitance

Antenna manufacturing technology	Cit [pF]
Wired	5 – 7
Etched	2 – 4
Printed	2 – 4

The capacitance of a possibly realized bridge C_{br} depends on the bridge length and bridge width.

Estimated value: $C_{br} = 1 - 5 pF$

An additional capacitance realized on the tag C_{in} depends on the capacitor area. This capacitance is difficult to estimate, so it is recommended to make a measurement of this tag capacitor.

$$C_c = C_{it} + C_{br} + C_{in}$$

4.2.3 Estimation of the connection capacitance C_{Con}

The connection capacitance can be estimated by choosing a value out of the following range:

$$C_{\text{Con}} = 0.5 - 2 \text{ pF}$$

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4.2.4 Calculation of objective antenna inductance L_o based on an estimated tag capacitance C_{plT}

$$C_{plT} = C_{ICT} + C_{Con} + C_{c}$$

With $C_{ICT} = 50 pF$

$$L_o = \frac{1}{\left(2 \cdot \pi \cdot f_{RT}\right)^2 \cdot C_{plT}}$$

With $f_{RT} = f_{ideal}$

4.3 Determination of objective inductance L_0

4.3.1 Rectangular (square) antennas

4.3.1.1 Calculation of inductance

The inductance of the antenna based on geometrical parameters estimates to:

$$L_{calc} = \frac{\mu_0}{\pi} \cdot [x_1 + x_2 - x_3 + x_4] \cdot N_c^p$$

with:

$$d = \frac{2 \cdot (t + w)}{\pi}$$

$$a_{avg} = a_o - N_c \cdot (g + w)$$

$$b_{avg} = b_o - N_c \cdot (g + w)$$

$$x_1 = a_{avg} \cdot \ln \left[\frac{2 \cdot a_{avg} \cdot b_{avg}}{d \cdot (a_{avg} + \sqrt{a_{avg}^2 + b_{avg}^2})} \right]$$

$$x_2 = b_{avg} \cdot \ln \left[\frac{2 \cdot a_{avg} \cdot b_{avg}}{d \cdot (b_{avg} + \sqrt{a_{avg}^2 + b_{avg}^2})} \right]$$

$$x_3 = 2 \cdot \left[a_{avg} + b_{avg} - \sqrt{a_{avg}^2 + b_{avg}^2} \right]$$

$$x_4 = \frac{a_{avg} + b_{avg}}{4}$$

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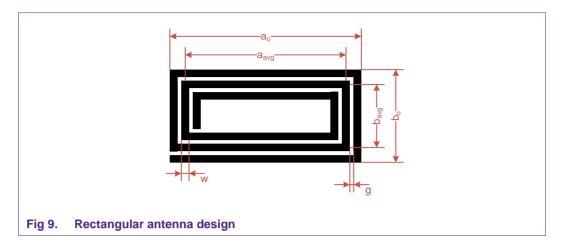


Table 3. Rectangular antenna parameter

rable 3. Rectangular antenna pa	arameter
Parameters	Description
<i>a</i> ₀ , <i>b</i> ₀	Overall dimensions of the antenna
aavg, bavg	Average dimensions of the antenna
t	Track thickness
W	Track width
g	Gap between the tracks
<i>N</i> _c	Number of turns
d	Equivalent diameter of the track
p	Turn exponent

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4.3.2 Round antennas

The inductance of the antenna based on geometrical parameters estimates to:

$$L_{calc}[nH] = 2 \cdot l \cdot \left[\ln \frac{l}{d} - 1,07 \right] \cdot N^{p}$$

$$l = D_{avg} \cdot \pi$$

$$D_{avg} = D_{o} - N \cdot (g + w)$$

$$d = \frac{2 \cdot (w + g)}{\pi}$$

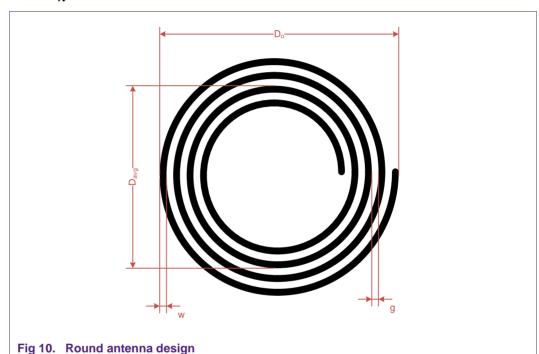


Table 4. Round antenna parameters

Parameter	Description
D _o	Antenna diameter [cm]
t	Track thickness
w	Track width
g	Gap between the tracks
<i>N</i> _c	Number of turns
d	Equivalent diameter of the track
p	Turn exponent
<i>D</i> _{avg}	Average antenna diameter [cm]
I	Average antenna circumference

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4.4 Determination of dimensional limits

4.4.1 Rectangular (square) antennas

4.4.1.1 Maximum antenna dimensions a_{max} , b_{max}

The maximum dimensions of the antenna a_{max} and b_{max} are determined by the application which the tag is designed for.

Therefore, the starting point for the calculations is always:

 $a_0 = a_{\text{max}}$

 $b_0 = b_{\text{max}}$

The actual overall dimension of the antenna a_0 and b_0 can also be smaller than a_{max} and b_{max} in some cases (large tags) but the product $A_c \cdot N_c$ should kept always as high as possible (see "minimal threshold field strength" in section 2.4)!

$$A_c = a_{avg} \cdot b_{avg}$$

The active antenna A_{active} area is the product of average antenna area A_{c} and the number of turns N_{c} .

$$A_{active} = A_c \cdot N_c$$

4.4.1.2 Gap between the tracks g

The minimal gap between the tracks g_{min} is defined by the antenna production process. To get the highest possible antenna area:

$$g = g_{\min}$$

4.4.1.3 Track thickness t and track width w

For aluminum and copper antennas a track thickness of $t \ge 30 \mu m$ should give a sufficient quality factor even for a small track width w.

For printed antennas, the track thickness should be chosen as high as possible to get highest possible quality factors.

The track width w remains as fit-parameter for the calculation of the inductance L_{calc} . It is recommended to choose the track width w not to small as it influences the quality factor Q_{pc} and a variation of the track width w is needed for the second matrix run as well.

4.4.1.4 Estimation of turn exponent p

Under the assumption that all turns are concentrated on the outline of the antenna, so all magnetic flux passes the enclosed area of all turns (no stray field) and the magnetic coupling between the turns is 100%, the inductance is proportional to N_c^2 .

As this is not possible to realize the following table gives estimated values for the turn exponent *p* for different antenna manufacturing technologies.

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Table 5. Turn exponent p

Antenna manufacturing technology	р
Wired	1.8 – 1.9
Etched	1.75 – 1.85
Printed	1.7 – 1.8

4.4.2 Round antennas

4.4.2.1 Maximum antenna dimension D_{max}

The maximum dimension of the antenna D_{max} is determined by the application the tag is designed for.

Therefore, the starting point for the calculation is always:

$$D_o = D_{\text{max}}$$

The actual overall dimension of the antenna D_0 can also be smaller than D_{max} in some cases (large tags) but the product $A_0 \cdot N_0$ should kept always as high as possible.

$$A_c = D_{avg}^2 \cdot \frac{\pi}{4}$$

4.4.2.2 Gap between tracks g

The minimal gap between the tracks g_{min} is defined by the antenna production process.

To get the highest possible average antenna area:

$$g = g_{\min}$$

4.4.2.3 Track thickness t and track width w

For aluminum and copper antenna a track thickness of $t \ge 30 \mu m$ should give a sufficient quality factor even for a small track width w.

For printed antennas, the track thickness should be chosen as high as possible to get the highest possible quality factor.

The track width w remains as fit-parameter for the calculation of the inductance L_{calc} . It is recommended to choose the track width w not to small as it influences the quality factor Q_{pc} and a variation of the track width w is needed for the second matrix run as well.

4.4.2.4 Estimation of turn exponent p

Under the assumption that all turns are concentrated on the outline of the antenna, so all magnetic flux passes the enclosed area of all turns (no stray field) and the magnetic coupling between the turns is 100%, the inductance is proportional to N_c^2 .

As this is not possible to realize the following table gives estimated values for the turn exponent p for different antenna manufacturing technologies.

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Table 6. Turn exponent p

Antenna manufacturing technology	р
Wired	1.8 – 1.9
Etched	1.75 – 1.85
Printed	1.7 – 1.8

4.5 Definition of matrix run

4.5.1 Rectangular (square) antennas

4.5.1.1 Matrix run definition

The following values should be fixed before starting the matrix run calculations:

$$L_0$$
, p , a_{max} , b_{max} , t , g

The calculation of the inductance L_0 is based on estimated values and the calculation of the antenna parameters at this time can only be made approximately. Therefore, the inductance of the matrix run antennas should be varied within \pm 20% of the estimated objective inductance L_0 .

i... first matrix run antenna number

Table 7. First matrix run

Table 1.	I II St III ati ix i uii					
i	1	2	3	4	5	
$L_{ m calc,i}$	0.8 <i>L</i> o	0.9 <i>L</i> _o	Lo	1.1 <i>L</i> _o	1.2 <i>L</i> _o	
a o, i						
b₀, i Nc, i						
N _{c, i}						
Wi						

The antenna parameters $a_{0,i}$, $b_{0,i}$, $N_{c,i}$ and w_i must be experimentally varied until $L_{calc,i}$ is equal to the given percentage of the estimated objective inductance L_0 . During this antenna parameter determination, it must be always attempted to keep the product

 $A_{c,i} \cdot N_{c,i}$ as high as possible!

4.5.2 Round antennas

4.5.2.1 Matrix run definition

The following values should be fixed before starting the matrix run calculations:

$$L_{o}$$
, p , D_{max} , t , g

The calculation of the inductance L_0 is based on estimated values and the calculation of the antenna parameters at this time can only be made approximately. Therefore, the inductance of the matrix run antennas should be varied within \pm 20% of the estimated objective inductance L_0 .

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i... first matrix run antenna number

Table 8. First matrix run

i	1	2	3	4	5
L _{calc, i}	0.8 <i>L</i> _o	0.9 <i>L</i> _o	Lo	1.1 <i>L</i> _o	1.2 L _o
<i>D</i> o, i					
N _{c, i}					
<i>W</i> i					

The antenna parameters $D_{0,i}$, $N_{c,i}$ and w_i must be experimentally varied until $L_{\text{calc},i}$ is equal to the given percentage of the estimated objective inductance L_0 . During this antenna parameter determination, it must be always attempted to keep the product $A_{c,i} \cdot N_{c,i}$ as high as possible!

4.6 Final antenna/ tag

To decide which antenna fits the requirements of resonance frequency best, it is recommended to measure the tag resonance frequency and compare with the targets defined at the beginning (f_{deal}).

For this measurement, the ISO setup or a measurement as described in 3.1.3 or 3.1.4 is recommended.

Table 9. Result table

k	1	2	3	4	5	
f_{R}						

4.6.1 Choosing the best antenna

Calculate the difference between the measured resonance frequency f_R and the ideal resonance frequency $f_{\rm ideal}$

$$\Delta f_{Ideal-R,j} = \left| f_{Ideal} - f_{R,j} \right|$$

Table 10. Optimum antenna

Table IV.	Optimum antenna				
j	1	2	3	4	5
$f_{Ideal\text{-}R,j}$					

The optimum antenna is the antenna that's nearest to f_{Ideal} .

$$\Delta f_{Ideal-R,j} = Minimum$$

Table 11. Summary table of parameters of antenna *j* (rectangular)

Paramete	er Value
J	
$L_{ m pc,j}$	
L _{pc,j} C _{c,j} a _{o,j} b _{o,j} N _{c,i}	
a _{o,j}	
b o,j	
<i>N</i> _{c,j}	
Wj	

Table 12. Summary table of parameters of antenna *j* (round)

Parameter	Value
J	
L _{pc,j}	
C _{c,j}	
<i>D</i> o,j	
$egin{aligned} L_{ m pc,j} \ C_{ m c,j} \ D_{ m o,j} \ N_{ m c,j} \ \end{aligned}$	
₩ _j	

4.7 Determination of best antenna parameters

If there is no antenna fitting to your requirements up to here, it is possible to do a second optimization step – a second matrix run.

4.7.1 Rectangular antennas

4.7.1.1 Equivalent circuit measurement and evaluation of antennas

The parallel equivalent circuit of the matrix run antennas must be determined (see also section $\underline{3}$).

Table 13. Measurement results

	modean on one					
i	1	2	3	4	5	
$C_{c,i}$						
L _{pc,i}						
C _{c,i} L _{pc,i} R _{pc,i} Q _{pc,i}						
Q _{pc,i}						

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4.7.1.2 Calculation of objective antenna inductance $L_{o,i}$

The value of the antenna capacitance $C_{c,i}$ is determined for all antennas now. These values are used to calculate the objective antenna inductance $L_{c,i}$ for all antennas.

$$C_{plT,i} = C_{ICT} + C_{Con} + C_{c,i} \label{eq:continuous}$$

$$L_{o,i} = \frac{1}{\left(2 \cdot \pi \cdot f_{RT}\right)^2 \cdot C_{plT,i}}$$

with $f_{RT} = f_{Ideal}$

4.7.1.3 Minimal difference between $L_{pc,i}$ and $L_{o,i}$

The optimum antenna of the matrix run is the one where the difference of measured inductance $L_{pc,i}$ and objective inductance $L_{o,i}$ is a minimum.

$$\Delta L_i = \left| L_{pc,i} - L_{o,i} \right|$$

Table 14. Inductance comparison

Table 14.	illuuctalice c	Ulliparisuli				
i	1	2	3	4	5	
$L_{ m pc,i}$						
$L_{o,i}$						
$\Delta L_{\rm i}$						

The antenna number I with minimum ΔL_i : j=i

j... Antenna number with minimum ΔL_i

Table 15. Parameter summary

rable 13. Farameter Summary	
Parameter	Value
j	
$\mathcal{L}_{pc,j}$	
C _{c,j}	
a _{0,j}	
L _{pc,j} C _{c,j} a _{o,j} b _{o,j} N _{c,j}	
N _{c,j}	
wj	

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Usually the antenna chosen here is the final antenna design for NTAG designs. If more exact tuning is necessary for the application, this antenna is the starting point for the second matrix calculation.

4.7.1.4 Determination of turn exponent p

For the chosen antenna *j* the precise turn exponent *p* can be calculated now.

$$\begin{split} a_o &= a_{o,j} \\ b_o &= b_{o,j} \\ L_{pc,j} &= L_{calc} = \frac{\mu_0}{\pi} \cdot \left[x_1 + x_2 + x_3 + x_4 \right] \cdot N_{c,j}^p \\ p &= \frac{\ln \left(\frac{L_{pc,j} \cdot \pi}{\mu_0 \cdot \left[x_1 + x_2 + x_3 + x_4 \right] \right)}{\ln N_{c,j}} \end{split}$$

4.7.2 Round antennas

4.7.2.1 Equivalent circuit measurement and evaluation of antennas

The parallel equivalent circuit of the matrix run antennas must be determined (see also section 3).

Table 16. Measurement results

i	1	2	3	4	5	
$C_{c,i}$						
L _{pc,i} R _{pc,i} Q _{pc,i}						
$R_{ m pc,i}$						
$Q_{ m pc,i}$						

4.7.2.2 Calculation of the objective antenna inductance $L_{o,i}$

The value of the antenna capacitance $C_{c,i}$ is determined for all antennas now. These values are used to calculate objective antenna inductance $L_{c,i}$ for all antennas.

$$C_{plT,i} = C_{ICT} + C_{Con} + C_{c,i}$$

$$L_{o,i} = \frac{1}{(2 \cdot \pi \cdot f_{RT})^2 \cdot C_{plT,i}}$$

with $f_{RT} = f_{Ideal}$

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4.7.2.3 Minimal difference between $L_{pc,i}$ and $L_{o,i}$

The optimum antenna of the matrix run is the one where the difference of measured inductance $L_{pc,i}$ and objective inductance $L_{o,i}$ is a minimum.

$$\Delta L_i = \left| L_{pc,i} - L_{o,i} \right|$$

Table 17. Inductance comparison

	madotano o	· · · · par · · o o · ·				
i	1	2	3	4	5	
$L_{ m pc,i}$						
$L_{o,i}$						
$\Delta L_{\rm i}$						

The antenna number i with minimum ΔL_i : j = i

 $j \dots$ Antenna number with minimum ΔL_j

Table 18. Parameter summary

Parameter	Value
j	
Lpc.j Cc.j Do.j Nc.j	
C _{c,j}	
$D_{0,j}$	
N _{c,j}	
Wj	

Usually the antenna chosen here is the final antenna design for NTAG designs. If more exact tuning is necessary for the application, this antenna is the starting point for the second matrix calculation.

4.7.2.4 Determination of turn exponent p

For the chosen antenna j the precise turn exponent p can be calculated now.

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$$D_{o} = D_{o,j}$$

$$\ln \left(\frac{L_{pc,j}}{2 \cdot l_{j} \cdot \left\{ \ln \left(\frac{l_{j}}{d_{j}} \right) \cdot 1,07 \right\}} \right)$$

$$p = \frac{\ln N_{c,j}}{\ln N_{c,j}}$$

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4.8 Second matrix run definition

4.8.1 Rectangular antennas

$$\begin{aligned} a_o &= a_{o,j} \\ b_o &= b_{o,j} \\ L_{calc} &= \frac{\mu_0}{\pi} \cdot \left[x_1 + x_2 + x_3 + x_4 \right] \cdot N_{c,j}^p \end{aligned}$$

4.8.2 Circular antennas

$$D_o = D_{o,j}$$

$$L_{calc}[nH] = 2 \cdot l \cdot \left[\ln \frac{l_j}{d_j} - 1,07 \right] \cdot N_{c,j}^p$$

4.8.3 Table for optimized antennas

The calculation of the inductance $L_{o,j}$ is still based on an estimated connection capacitance C_{Con} and also the antenna parameters have an influence on each other giving a nonlinear system. Therefore the inductance of the second matrix run antennas should be varied within \pm 8% of the objective inductance $L_{o,j}$.

k ... second matrix run antenna number

Table 19. Second matrix run

k	1	2	3	4	5
$L_{calc,k}$	0.92 L _{o,j}	0.96 L _{o,j}	$L_{o,j}$	1.04 <i>L</i> _{o,j}	1.08 <i>L</i> _{o,j}
Wk					

Only the antenna parameter track width w_k should be varied until $L_{\text{calc},k}$ is equal the given percentage of objective inductance $L_{\text{o,j}}$. In order to keep the accuracy of the calculation on a high level the overall dimension a_0 , b_0 , D_0 and the gap between the tracks g as well as the track thickness t should not be varied anymore.

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4.9 Determining optimized antenna from second matrix run

4.9.1 Tag with IC

The unloaded resonance frequency f_R of the second matrix run tags should be characterized (see section 3).

A tag must be determined where the value of the measured threshold resonance frequency $f_{RT,k}$ is closest to the optimal value. The used track width w_k of this tag defines the optimum track width for the antenna.

Table 20. Result table

. 45.0 20.	rtoodit tabio					
k	1	2	3	4	5	
f_{R}						

4.9.2 Choosing the best antenna

Calculate the difference between the measured resonance frequency f_{RT} , and the ideal resonance frequency f_{ideal} :

$$\Delta f_{ideal-R,k} = \left| f_{ideal} - f_{R,k} \right|$$

Table 21. Optimum antenna

k	1	2	3	4	5	
fideal-RTnom,k						

The optimum antenna is the antenna that's nearest to f_{ideal} .

$$\Delta f_{ideal-R,k} = Minimum \tag{1}$$

Table 22. Summary table of parameters of antenna k

Parameter	Value
k	
$L_{\rm pc,k}$	
C _{c,k}	
<i>a</i> o,k	
L _{pc,k} C _{c,k} a _{o,k} b _{o,k} N _{c,k}	
<i>N</i> c,k	
Wk	

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4.10 Antenna calculation tools

NXP provides their customers an excel-based calculation tool for rectangular and round antennas, to make the antenna design easier.

The rectangular antenna calculation tool is described in NTAG_CDG_SQUARE_V1.xlsx
Round antenna calculation is described in NTAG_CDG_ROUND_V1.xlsx

5. Antenna classes

5.1 Class definition

In [3] and [5] six antenna classes are defined (Class1 – Class6). All six classes describe different form factors and sizes.

For a NFC tag, NXP recommend to use "Class 3", "Class 4", "Class 5" or "Class 6" antennas.

5.1.1 "Class 3" antenna

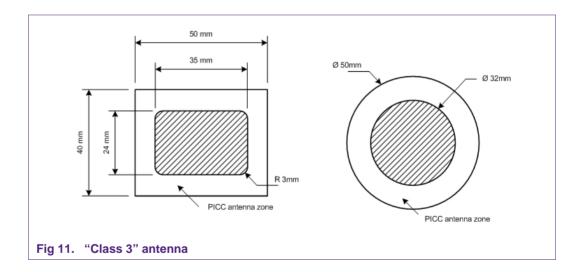
A "Class 3" antenna shall fulfill the following requirements.

The antenna shall be located within a zone defined either:

- External rectangle: 50 x 40mm
- Internal rectangle: 35 x 24mm, centered in the external rectangle, with 3mm corner radii

or

- external circle with diameter 50mm
- internal circle with diameter 32mm, concentric with the external circle



5.1.2 "Class 4" antenna

A "Class 4" antenna shall fulfill the following requirements.

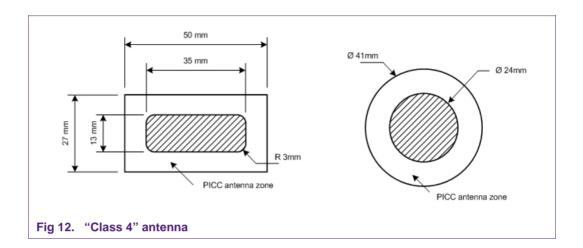
The antenna shall be located within a zone defined either:

- External rectangle: 50 x 27mm
- Internal rectangle: 35 x 13mm, centered in the external rectangle, with 3mm corner radii

or

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- external circle with diameter 41mm
- internal circle with diameter 24mm, concentric with the external circle



5.1.3 "Class 5" antenna

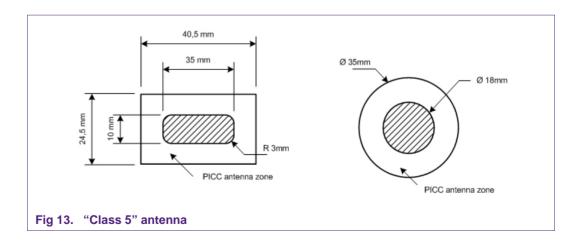
A "Class 5" antenna shall fulfill the following requirements.

The antenna shall be located within a zone defined either:

- External rectangle: 40,5 x 24,5mm
- Internal rectangle: 25 x 10mm, centered in the external rectangle, with 3mm corner radii

or

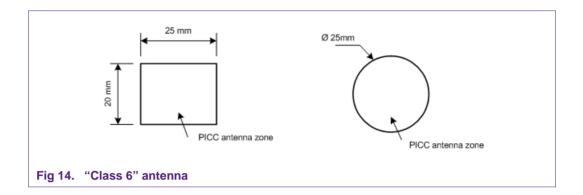
- external circle with diameter 35mm
- internal circle with diameter 18mm, concentric with the external circle



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5.1.4 "Class 6" antenna

The antenna of a "Class 6" design shall be located within a zone defined by either a rectangle of dimensions 25 x 20mm or a circle of 25mm diameter.



5.2 Reference antennas for NFC tags on PCBs

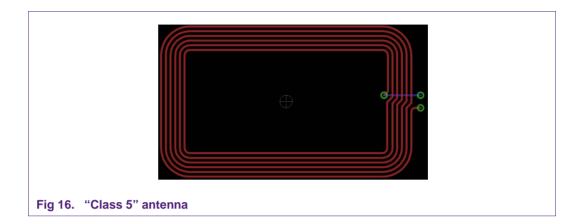
NXP also offers reference designs for the "Class4", "Class5" and "Class6" antennas as a NFC tag.

5.2.1 "Class 4" reference antenna



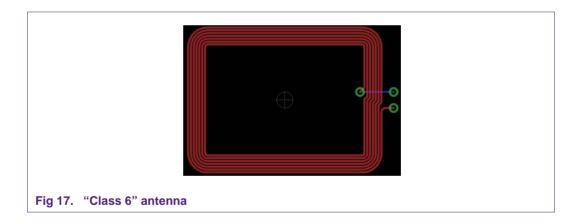
The Gerber file for the reference design: Class_4.zip

5.2.2 "Class 5" reference antenna



The Gerber file for the reference design: Class_5.zip

5.2.3 "Class 6" reference antenna



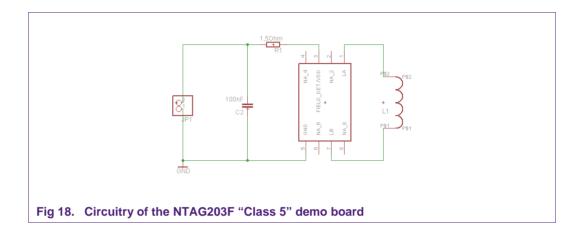
The Gerber file for the reference design: Class_6.zip

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6. NTAG demo boards and reference designs

NXP offers demo boards and reference designs for the NTAG203F with "Class 5" and "Class6" antennas.

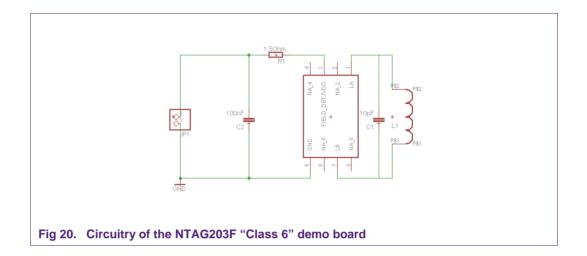
6.1 NTAG 203F demo and reference board "Class 5" antenna





The Eagle files for the reference design: Class_5-NTAG203F.zip

6.2 NTAG 203F demo and reference board "Class 6" antenna



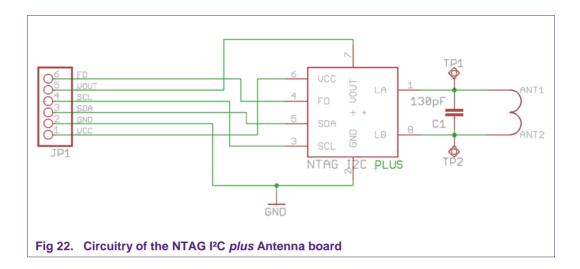


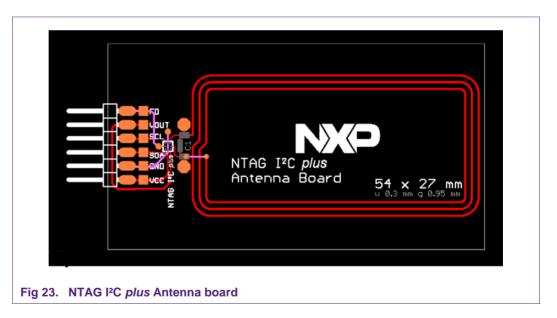
The Eagle files for the reference design: Class_6-NTAG203F.zip

The "Class 6" antenna is designed with a ferrite foil to use in a metal environment. More detailed information about HF antenna design with ferrite can be found in the document: "Design of 13.56 MHz Smartcard Stickers with ferrite for payment and Authentication.pdf".

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6.3 NTAG I²C plus Explorer board antenna





The Eagle files for the reference design: https://nxp.com/downloads/en/printed-circuit-boards-reference-designs/SW3639.zip

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7. List of abbreviations

This document uses the following list of abbreviations:

Ac Average antenna area
Active antenna area
Area of antenna winding i

 a_{avg} , b_{avg} Average dimensions of the antenna a_{max} , b_{max} Maximum dimensions of the antenna Overall dimensions of the antenna

C_c Antenna capacitance C_{br} Bridge capacitance

Ccon Capacitance due the connection NTAG IC – antenna

C_{IC} NTAG IC input capacitance

Cict NTAG IC input capacitance for threshold condition

C_{in} Designed inlet capacitance

C_{it} Inter turn capacitance of the antenna C_{pl} Parallel equivalent capacitance of the inlet

C_{DIT} Parallel equivalent capacitance of the inlet for threshold condition

d Antenna wire diameter

f Frequency

 f_{op} Operating frequency

f_R Resonance frequency of the inlet

f_{RT} Threshold resonance frequency of the inlet

g Gap between the tracks H_T Threshold field strength

H_{Tmin} Minimal threshold field strength

H_{Top} Threshold field strength at operating frequency

l₁ Reader antenna current

L_{calc} Inductance calculated out of the geometrical antenna parameters

*L*_o Objective inductance of the antenna

 $L_{\rm pc}$ Parallel equivalent inductance of the antenna $L_{\rm sc}$ Serial equivalent inductance of the antenna

Mutual inductance between the inlet antenna and reader antenna

N_c Number of turns of the antenna

p Turn exponent

Q Quality factor of the inlet

Q_{pc} Quality factor of the antenna for parallel equivalent circuit

Q_{sc} Quality factor of the antenna for serial equivalent circuit

Q_T Threshold quality factor of the inlet

Resistance of the connection NTAG IC – antenna

R_{IC} NTAG IC input resistance

RICT NTAG IC input resistance for threshold condition

R_{pc} Parallel equivalent resistance of the antenna

R_{pl} Parallel equivalent resistance of the inlet

 R_{plT} Parallel equivalent resistance of the inlet at threshold condition

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R_{sc} Serial equivalent resistance of the antenna

t Track thickness

V_{LA-LB} NTAG IC input voltage

V_{LA-LB min} Minimal voltage level for NTAG IC operation

w Track width

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Reference documentation 8.

NXP provides several documents to support the development of customized antennas.

8.1 **Datasheets**

NXP provides the following datasheets:

- NTAG203F, NFC Forum Type 2 Tag compliant IC with 144 bytes user memory and field detection; http://www.nxp.com/restricted_documents/53420/NTAG203F.pdf
- NTAG210 212, NFC Forum Type 2 Tag compliant IC with 48/128 bytes user memory; http://www.nxp.com/documents/data_sheet/NTAG210_212.pdf
- NTAG213 215 216, NFC Forum Type 2 Tag compliant IC with 144/504/888 bytes user memory
 - http://www.nxp.com/documents/data_sheet/NTAG213_215_216.pdf
- NTAG213F 216F, NFC Forum Type 2 Tag compliant IC with 144/888 bytes user memory and field detection http://www.nxp.com/documents/data sheet/NTAG213F 216F.pdf
- NT3H1101/NT3H1201, NTAG I²C Energy harvesting NFC Forum Type 2 Tag with field detection pin and I2C interface http://www.nxp.com/documents/data_sheet/NT3H1101_1201.pdf
- NT3H2111/NT3H2211, NTAG I2C plus, NFC Forum Type 2 Tag compliant IC with I2C interface http://www.nxp.com/documents/data_sheet/NT3H2111_2211.pdf
- NHS3100, Temperature logger https://www.nxp.com/docs/en/datasheet/NHS3100.pdf
- NHS3152, Therapy adherence resistive monitor https://www.nxp.com/docs/en/datasheet/NHS3152.pdf
- LPC8N04, 32-bit ARM Cortex-M0 microcontroller; 32 kB flash and 8 kB SRAM; NFC/RFID ISO 14443 type A interface https://www.nxp.com/docs/en/datasheet/LPC8N04.pdf

8.2 Application notes

NXP provides the following application notes:

- AN11141; NTAG203F, How to use the FD pin; http://www.nxp.com/documents/application_note/AN11141.pdf
- AN11383, NTAG21x Field Detection and sleep mode feature http://www.nxp.com/documents/application note/AN11383.pdf
- AN11350; NTAG Originality Signature Validation; http://www.nxp.com/documents/application note/AN11350.pdf

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8.3 ISO/IEC standards

- [1] ISO/IEC 10373-6:2011, Identification cards Test methods Part 6: Proximity cards
- [2] ISO/IEC 14443-1:2008, Identification cards Contactless integrated circuit cards Proximity cards Part 1: Physical characteristics
- [3] ISO/IEC 14443-1:2008/Amd 1:2012, Additional PICC classes
- [4] ISO/IEC 14443-2:2010, Identification cards Contactless integrated circuit cards Proximity cards Part 2: Radio frequency power and signal interface
- [5] ISO/IEC 14443-2:2010/Amd 2:2012, Additional PICC classes
- [6] ISO/IEC 14443-3:2011, Identification cards Contactless integrated circuit cards Proximity cards Part 3: Initialization and anticollision
- [7] ISO/IEC 18092:2004, Information technology Telecommunications and information exchange between systems — Near Field Communication — Interface and Protocol (NFCIP-1)
- [8] ISO/IEC 21481:2012, Information technology Telecommunications and information exchange between systems — Near Field Communication Interface and Protocol -2 (NFCIP-2)

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NTAG — is a trademark of NXP B.V.

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10. List of figures

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